

# **Electronic Circuit Failure Detection Using Thermal Image**

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## Abstract

This inspection of electronic circuits can be performed either by connection with voltage supply and without voltage supply. However, inspections during the working circuit may invite serious harm and damage to the components in the circuit. Usually, the method used is to measure the current and voltage values in the circuit based on the reading reference when the circuit is in normal condition. There is another method that can help check the current circuit condition by using image processing method. In this paper, we presented our study on electronic component failure detection using thermal image processing. The thermal image was collected from linear regulated dc power supply. The observation is focused on the thermal produce by capacitor and voltage regulator IC. The image has been analysed using Red Green Blue (RGB) and Hue Saturation Value (HSV) colour space. The pixel of colour was analysed using mean value. The result showed there is significant different heat produced by the component in normal condition and failure condition. Through the observation, it was found that the high heat was recorded if wrong polarity of the components in the circuit.

#### **Subject Areas**

**Electronic Engineering** 

## **Keywords**

Thermal Image, Colour Space, Electronic Circuit, Image Processing

# **1. Introduction**

The thermal camera has been developed in recent decades and now become a new type detection technology. The first thermographic camera (night vision) was introduced in 1929 by KalmanTihanyi for anti-aircraft defense in Britain. Thermal infrared (TIR) imagers typically operate in the midwave (3 to 5  $\mu$ m) or long-wave (8 to 14  $\mu$ m) infrared region [1]. Basically objects that are detected by thermographic cameras depend on the temperature difference of the object and the surrounding temperature conditions.

Nowadays, detection technology using thermal image is rapidly increasing and being used in various applications. The study of pipe leakage found that thermal images were one of the most accurate methods of detecting gas leakage [2] [3]. This technique also can be applied to detect breast cancer [4]. Other than that, study on bacteria detection showed that each pixel from the thermal image presented a different temperature colour due to the thousands of bacteria contained in it [5]. The study on early detection of land slide demonstrated that temperature and colour indication play important role in indicated the spots of water saturation position [6]. Besides that, thermal image camera has been proved that can detect buried object and discovered that there is significant different image capture during day times and night times [7].

Thermal imaging can be used in various electrical applications such as cable boards, bus bar systems, overhead wires, electrical machines and drives, electrical equipment in mobile installations [8]. This technique is also used in detecting equipment damage, connection and damage of electronic components [8] [9] [10] [11]. IC testing using heat techniques found that this method increases the efficiency of the test system in finding IC defects in PCB [12]. In addition, this method is also used in detecting short-circuits for electric motors. According to a previous research, fault component can be detected using thermal image, because some object will produce heat whether in the hottest or in the coolest situation.

The practical process of teaching in the electrical engineering lab requires the lecturer to examine the student's circuit. This process is important to avoid any damage to the appliance when the circuit is switched on. Often the components damage due to incorrect connection and reverse polarity. Additionally, this condition still occurs although the circuit has been checked manually. Although, there are many electrical devices that can be used to check circuit conditions, there is an alternative method that can be used to detect faults in components which is thermal imagery. In this paper, the thermal image is proposed to detect fault electronic component. This paper is focused on incorrect connection and reverse polarity for Regulator Voltage IC and capacitor.

#### 2. Methodology

The method in this study involves 4 sections namely data collection, image cropping, filtering and feature colour extraction and decision. The methodology process is showed in **Figure 1**. Data collection is the process whereby how the data were collected. In this section, the device (thermal camera) and MATLAB software are used in order to get the data. Image cropping can be defined as the process that we want to resize the image and focus at the interest area. The next section is filtering process which is image is enhanced by image filtering and

noise removing. The thermal image is then through the features extraction section to extracted colour information from each image samples.

Sample image were acquired by using a thermal camera and all image will be transfer to computer. Thermal camera used for this project is FLIR C2 Compact Thermal Imaging Camerathat has 4800 measurement pixels. For this project, heat condition produce by capacitor and voltage regulator IC will be observed. The circuit used in this project is linear regulated dc power supply as shown in **Figure 2** bellow.

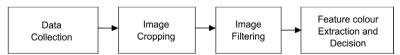
Linear regulated dc power supply circuit used in this study has three sections which is brdge rectifier, filter and voltage regulator. The bridge rectifier section consists of four diodses (D1-D4), while the filter section consists of 2 capacitors (C1 & C2) and the voltage regulator section using IC LM7812.

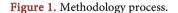
#### 3. Result and Analysis

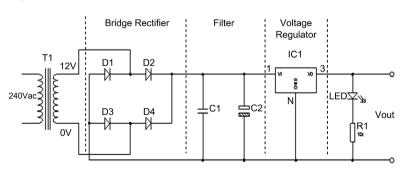
The thermal image from FLIR C2 Camera has been analysed for capacitor and voltage regulated IC. The image was observed at normal and failure condition. The sample image then was cropped and filtered using MATLAB software. In this study, mathematical statistic of the image has been analysed using different colour space which is Red Green Blue (RGB) and Hue Saturation Value (HSV). The comparison normal and failure condition image was showed in **Figure 3** and **Figure 4**.

Based on the general observation the image showed a significant difference between the two conditions. The heat will be freed by the components and can be clearly seen in **Figure 3**. **Table 1** showed the mean value of RGB and HSV.

Through the mean analysis of RGB and HSV colour space, there is significant difference in RGB colour space. For the analysis obtained from the mean value of HSV the difference is too small. Significant differences occurred in the RGB analysis where the normal values and the component failure values were compared as shown in **Figures 5-8**. Red and green components for incorrect connections increased for both components (C2 and IC1).



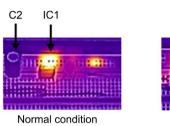


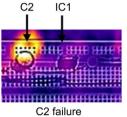




Component Condition	RGB			HSV		
	R	G	В	Н	S	V
C2 Normal	101.04	26.65	134.04	0.76	0.84	0.58
C2 Wrong Polarity	116.97	59.14	119.66	0.62	0.72	0.59
IC1 Normal	133.51	48.99	132.58	0.69	0.77	0.63
IC1 Wrong Polarity	140.78	66.20	128.04	0.65	0.68	0.63







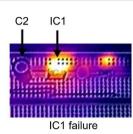
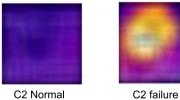


Figure 3. Normal and failure condition image.









IC1 Normal

IC1 failure

Figure 4. Normal and failure condition image after cropped and filtered.

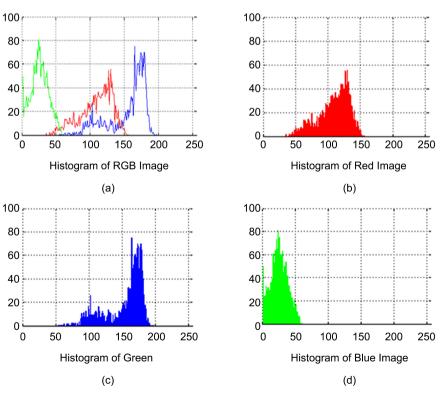


Figure 5. Normal condition RGB image of Capacitor C2.

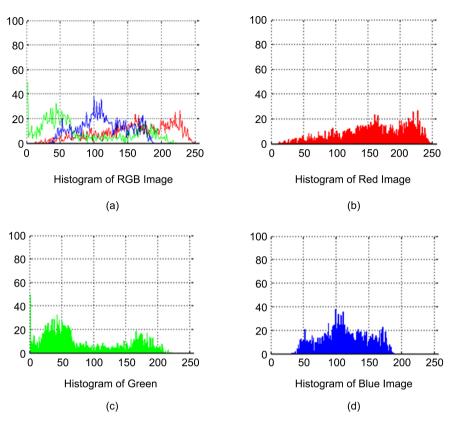
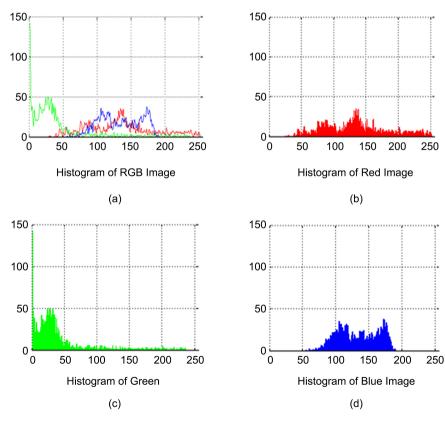


Figure 6. Wrong polarity condition RGB image of Capacitor C2.



**Figure 7.** Normal condition RGB image of IC1.

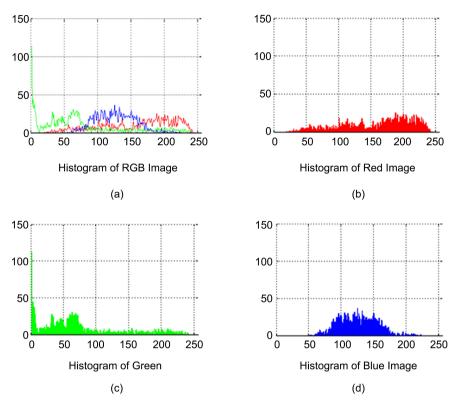


Figure 8. Wrong polarity condition RGB image of IC1.

## 4. Conclusion

As the conclusion, the study successfully distinguished normal and failure component using image processing. In this study, the influence of environmental temperature has been neglected. The data has been collected in open space within the laboratory. Thus, there is no uniform reference of hot and cold point reference during the experiment. In the future, it is recommended that the experiment be conducted in a closed room and the environmental temperature conditions should be recorded so that the value obtained is more accurate.

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# **Conflicts of Interest**

The authors declare no conflicts of interest regarding the publication of this paper.

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